

Notic of References Cit d	Application/Control No. 10/748,900	Applicant(s)/Patent Under Reexamination KIM ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0157806	08-2003	Nagahara et al.	438/694
	B	US-6,573,168 B2	06-2003	Kim et al.	438/586
	C	US-6,383,912 B1	05-2002	Chung et al.	438/624
	D	US-6,514,852 B2	02-2003	Usami, Tatsuya	438/624
	E	US-2003/0077894	04-2003	Ryu, Sang Wook	438/622
	F	US-6,724,069 B2	04-2004	Dalton et al.	257/642
	G	US-6,312,874 B1	11-2001	Chan et al.	430/314
	H	US-6,319,809 B1	11-2001	Chang et al.	438/597
	I	US-2003/0137055	07-2003	Trivedi, Jigish D.	257/774
	J	US-2001/0021581	09-2001	MOON et al.	438/637
	K	US-6,649,515 B2	11-2003	Moon et al.	438/637
	L	US-6,548,401 B1	04-2003	Trivedi, Jigish D.	438/638
	M	US-6,406,995 B1	06-2002	Hussein et al.	438/638

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,323,121 B1	11-2001	Liu et al.	438/633
	B	US-6,156,643 A	12-2000	Chan et al.	438/638
	C	US-2003/0119305	06-2003	Huang et al.	438/633
	D	US-5,539,255 A	07-1996	Cronin, John E.	257/750
	E	US-2003/0203321	10-2003	Ma et al.	430/316
	F	US-2003/0082905	05-2003	Hung et al.	438/633
	G	US-6,583,047 B2	06-2003	Daniels et al.	438/623
	H	US-6,218,287 B1	04-2001	Matsumoto, Akira	438/624
	I	US-6,060,380 A	05-2000	Subramanian et al.	438/618
	J	US-6,743,713 B2	06-2004	Mukherjee-Roy et al.	438/638
	K	US-6,309,962 B1	10-2001	Chen et al.	438/638
	L	US-2004/0100779	05-2004	Kraft, Robert	361/760
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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